Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/670,114	MOCHIDA ET AL.
Examiner	Art Unit
Dave Czekaj	2621

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated Previous Search	7/21/2006	DC	